

Cambridge University Press & Assessment 978-1-107-03238-5 — Electromigration in Metals Paul S. Ho , Chao-Kun Hu , Martin Gall , Valeriy Sukharev Copyright information

More Information

CAMBRIDGEUNIVERSITY PRESS

University Printing House, Cambridge CB2 8BS, United Kingdom

One Liberty Plaza, 20th Floor, New York, NY 10006, USA

477 Williamstown Road, Port Melbourne, VIC 3207, Australia

314-321, 3rd Floor, Plot 3, Splendor Forum, Jasola District Centre, New Delhi - 110025, India

103 Penang Road, #05-06/07, Visioncrest Commercial, Singapore 238467

Cambridge University Press is part of the University of Cambridge.

It furthers the University's mission by disseminating knowledge in the pursuit of education, learning, and research at the highest international levels of excellence.

www.cambridge.org

Information on this title: www.cambridge.org/9781107032385

DOI: 10.1017/9781139505819

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First published 2022

Printed in the United Kingdom by TJ Books Limited, Padstow Cornwall

A catalogue record for this publication is available from the British Library.

Library of Congress Cataloging-in-Publication Data

Names: Ho, P. S., author. | Hu, Chao-Kun, 1946- author. | Gall, Martin, author. | Sukharev, Valeriy, 1952- author.

Title: Electromigration in metals: fundamentals to nano-interconnects / Paul Ho, Chao-Kun Hu,

Martin Gall, Valeriy Sukharev.

Description: Cambridge ; New York, NY : Cambridge University Pres, 2022. \mid Includes bibliographical references and index.

Identifiers: LCCN 2021050167 (print) | LCCN 2021050168 (ebook) | ISBN 9781107032385 (hardback) | ISBN 9781139505819 (epub)

Subjects: LCSH: Interconnects (Integrated circuit technology)-Materials. | Metals-Electric properties. | Electrodiffusion.

Classification: LCC TK7874.53 .H62 2022 (print) | LCC TK7874.53 (ebook) |

DDC 621.3815-dc23/eng/20220110

LC record available at https://lccn.loc.gov/2021050167

LC ebook record available at https://lccn.loc.gov/2021050168

ISBN 978-1-107-03238-5 Hardback

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